

# Even-Odd Jitter (EOJ) Test Method IEEE 802.3ck Electrical ad-hoc

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*2020-09-16*

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# Background / Goals

- Review current EOJ measurement methodology
- The Unintentional Problem Impacting EOJ Measurements
- Review EOJ measurement results performed with different CR loop bandwidths
- Recommendations to consider in anticipation of comments to be submitted against draft 1.3

# Output Jitter: IEEE 802.3ck

**Table 162-10** – Summary of transmitter specifications at TP2  
Even-odd jitter (max 19 mUI) references Subclause 162.9.3.3.

## 162.9.3.3 Output jitter

Output jitter is characterized by three parameters,  $J_{3u}$ ,  $J_{RMS}$ , and even-odd jitter. These parameters are calculated from measurements with a single transmit equalizer setting to compensate for the loss of the transmitter package and host channel. The equalizer setting is chosen to minimize any or all of the jitter parameters.

$J_{3u}$  and  $J_{RMS}$  are calculated using the measurement method specified in 120D.3.1.8.1.  $J_{3u}$  is defined as the time interval that includes all but  $10^{-3}$  of  $f_j(t)$ , from the 0.05th to the 99.95th percentile of  $f_j(t)$ .

Even-odd jitter is calculated using the measurement method specified in 120D.3.1.8.2.

**Table 120F-1** – Transmitter electrical characteristics at TP0v  
Even-odd jitter (max 19 mUI) references 120F.3.1.3

## 120F.3.1.3 Output jitter

Output jitter is characterized by three parameters:  $J_{4u}$ ,  $J_{RMS}$ , and even-odd jitter. These parameters are calculated from measurements with a single transmit equalizer setting to compensate for the loss of the transmitter package and test fixture. The equalizer setting is chosen to minimize any or all of the jitter parameters.

$J_{4u}$  and  $J_{RMS}$  are calculated using the jitter measurement method specified in 120D.3.1.8.1.

Even-odd jitter is calculated using the jitter measurement method specified in 120D.3.1.8.2.

Both EOJ measurements in IEEE  
802.3ck reference EOJ  
measurement method outlined in  
IEEE-2018 Annex 120D.3.1.8.2  
(see next slide)

# Even-Odd Jitter (EOJ) Measurement defined in 120D.3.1.8.2

REFERENCE: IEEE 802.3-2018

IEEE Std 802.3-2018, IEEE Standard for Ethernet  
SECTION EIGHT

## 120D.3.1.8.2 Even-odd Jitter

For one of the 12 specific transitions in PRBS13Q in Table 120D-4:

- a) Trigger once in 3 repeats of the PRBS13Q test pattern
  - 1) Obtain the mean time ( $T_3$ ) for this transition in the first PRBS13Q.
  - 2) Obtain the mean time ( $T_4$ ) for the same transition in the second PRBS13Q.
- b) The difference between the two means ( $T_4 - T_3$ ), is the estimated period of the repeating pattern

For each of the 12 specific transitions in PRBS13Q in Table 120D-4:

- a1) Trigger once in 2 repeats of the PRBS13Q test pattern.
  - 1) Obtain the mean time ( $T_1$ ) for the specific transition in the first PRBS13Q.
  - 2) Obtain the mean time ( $T_2$ ) for the same transition in the second PRBS13Q.
- b1) Calculate even-odd jitter for this transition as  $|(T_2 - T_1) - (T_4 - T_3)|$

Even-odd jitter EOJ is the maximum of the 12 measurements.

NOTE 1—Both of ( $T_2 - T_1$ ) and ( $T_4 - T_3$ ) are about 8191 UI, which is much larger than the EOJ value. Hence, each of  $T_1$  through  $T_4$  should have high precision.

NOTE 2—Even-odd jitter has been referred to as *duty cycle distortion* by other Physical Layer specifications for operation over electrical backplane or twinaxial copper cable assemblies (see 72.7.1.9). The term *even-odd jitter* is used here to distinguish it from the duty cycle distortion referred to by Physical Layer specifications for operation over fiber optic cabling.

**Annex 120D.3.1.8.2:** EOJ is measured with a PRBS13Q pattern using a Clock Recovery Unit (CRU) with loop BW 4 MHz and slope 20 dB/dec.

IEEE Std 802.3-2018, IEEE Standard for Ethernet  
SECTION EIGHT

Table 120D-4—PRBS13Q pattern symbols used for jitter measurement

Label	Description	Gray coded PAM4 symbols	Index of first symbol	Index transition begins	Index transition ends	Index of last symbol	Threshold level
REF	Reference for symbol index	3333333	1	—	—	7	—
R03	0 to 3 rise	10000 330	1830	1834	1835	1837	$(V_0+V_3)/2$
F30	3 to 0 fall	23333 001	1269	1273	1274	1276	
R12	1 to 2 rise	0111111 2222221	3638	3644	3645	3651	$(V_1+V_2)/2$
F21	2 to 1 fall	022222 113	1198	1203	1204	1206	
R01	0 to 1 rise	100000 113	6835	6840	6841	6843	$(V_0+V_1)/2$
F10	1 to 0 fall	21111 003	2992	2996	2997	2999	
R23	2 to 3 rise	32222 330	6824	6828	6829	6831	$(V_2+V_3)/2$
F32	3 to 2 fall	033333 2222223	7734	7739	7740	7746	
R02	0 to 2 rise	10000 223	3266	3270	3271	3273	$(V_0+V_2)/2$
F20	2 to 0 fall	122222 0000002	7282	7287	7288	7294	
R13	1 to 3 rise	0111111 331	133	138	139	141	$(V_1+V_3)/2$
F31	3 to 1 fall	23333 112	7905	7909	7910	7912	

The jitter is measured with a clock recovery unit (CRU) with a corner frequency of 4 MHz and a slope of 20 dB/decade. Jitter measurements are performed with transmitters on all lanes enabled and using identical transmitter equalizer settings. Transmitters on lanes not under test transmit PRBS13Q, or a valid 200GBASE-R or 400GBASE-R signal. PRBS13Q is described in 120.5.11.2.2.

The  $J_{4u}$ ,  $J_{RMS}$ , and Even-odd jitter specifications shall be met regardless of the transmit equalization setting.

# Even-Odd Jitter (EOJ) Max Specs

REFERENCE: IEEE 802.3-2018 VS IEEE 802.3 DRAFT 1.3

## IEEE 802.3bs/cd (IEEE 802.3-2018)

- Baud Rate: 26.5625 GBd
- EOJ Max: 19 mUI = **715 fs**

## IEEE 802.3ck Draft 1.3

- Baud Rate: 53.125 GBd
- EOJ Max: 19 mUI = **358 fs**

# of mUI is the same, but absolute time is reduced by 50%.

- Has root cause for EOJ on new 53 GBd transmitter designs been able to scale accordingly?
- Was measurement repeatability considered when selecting EOJ max spec of 358 fs? More on this later...
- **Bottom Line: EOJ has extremely low margins in 802.3ck Draft 1.3.**

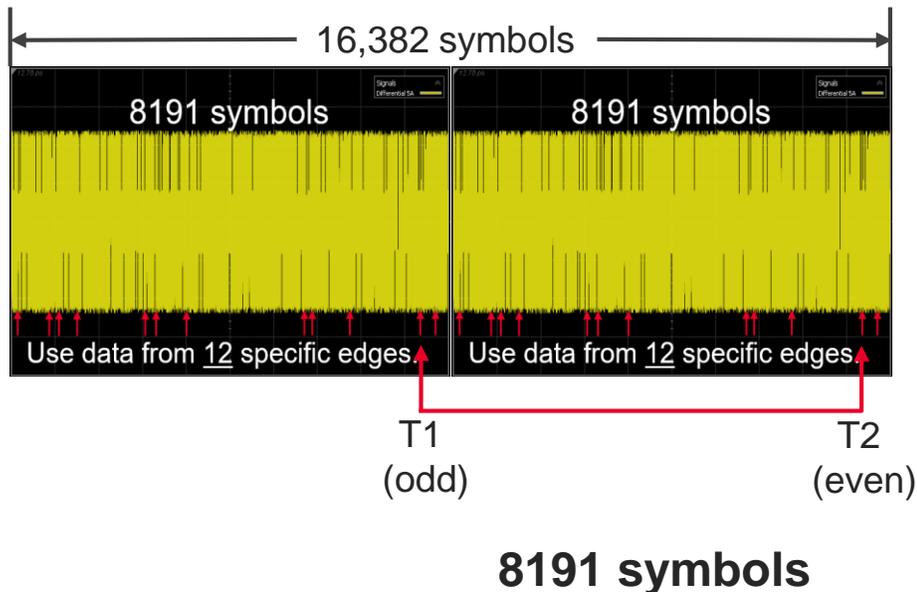
# Even-Odd Jitter

## SUB-HARMONICS INTRODUCED BASED ON F\_BAUD AND PATTERN REPETITION RATE

Identifies jitter impairments due to  $\frac{1}{2}$  rate clock systems (rising or falling clock edge), including impairments from Tx designs that generate PAM4 signals from two independent NRZ signals (-> need to characterize all 12 combinations of PAM4 transitions).

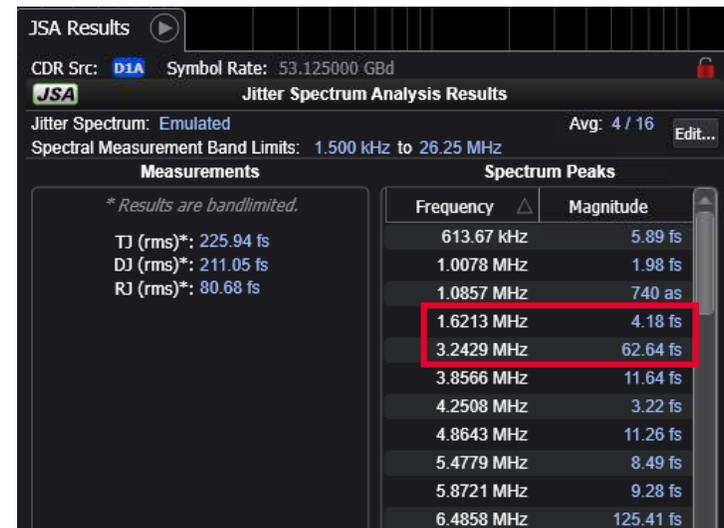
The Standard intended to measure the **timing differences between “even” and “odd” versions of the same edge.**

Note - When using a PRBS13Q pattern to characterize EOJ, this places the “even” and “odd” transitions being compared **8191 symbols apart.**



**Sub-Harmonics of EOJ are created based on Fbaud and Pattern Length:**

- Baud Rate: 53.125 Gbd
- PRBS13Q Pattern Length: 8191 Symbols
- Spectral Component =  $F_{\text{baud}} / (2 * \text{PatternLength}) = 3.24 \text{ MHz}$  (in-band)

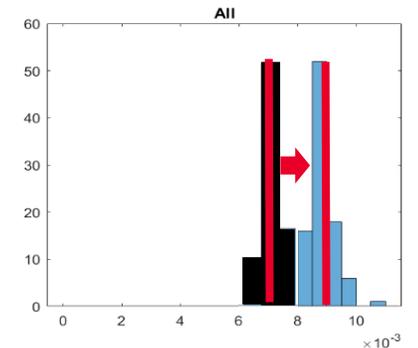


# Unexpected Problem Impacting EOJ Measurements

## COMBINATION OF FBAUD, PATTERN LENGTH, CRU LOOP BW

In practice, the EOJ result is impacted by the CDR loop BW and the selected pattern length.

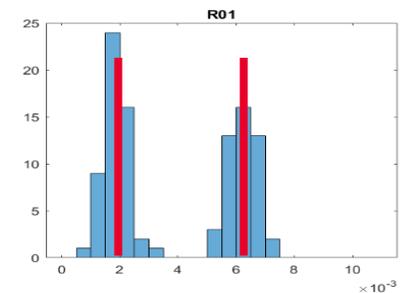
- EOJ from DUT:** CDR responds to the EOJ in the signal, is filtered by the Jitter Transfer Function (JTF) low-pass response, and moves the phase of the clock.
  - Spectral Component =  $F_{\text{baud}} / (2 * \text{PatternLength}) = 53.125 \text{ GBd} / 16,382 \text{ symbols} = \underline{3.24 \text{ MHz}}$  (in-band)
  - Normal distribution, increases/decreases the amplitude of the EOJ component based on phase relationship.
  - But EOJ algorithm always records the maximum of the of the 12 edges (worst case result), so EOJ result will always be increased due to the component (sub-harmonic) of EOJ that falls within the loop BW of the CDR.



- EOJ from CDR:** If ½ rate hardware CR does not have exactly 50% duty cycle, it introduces its own F/2 jitter.

- Spectral Component =  $F_{\text{baud}} / (2 * \text{PatternLength}) = 53.125 \text{ GBd} / 16,382 \text{ symbols} = \underline{3.24 \text{ MHz}}$  (in-band) .
- #2 can “interact” with #1 and create bi-modal EOJ on top of #1 (increased EOJ).

- Neither of these interactions are what the EOJ measurement is trying to characterize. Efforts should be taken to minimize the impact CR on the measurement.



# What can be done?

Since “Real” systems don’t have repetitive patterns that create this type of issue, it is our belief that any impairment of EOJ due to this relationship is unintended by the standard.

Is this understanding true? That is, CR loop BW of 4 MHz and test pattern length were chosen independently with no intent to create this interaction.

If our understanding is correct, the “interaction” effect can be mitigated if EOJ is measured with:

## 1. A lower CR Loop BW.

- Allow CR loop BW to be lowered from 4 MHz to x MHz (Example: ~ 100 kHz).=> Simple
- **See data that follows.**

## 2. A “clean” reference clock (no CDR)

- Not readily available in many systems. => **Not practical.**

## 3. A shorter pattern such as PRBS9Q

- Not defined in the Standard...a pretty big change. => **Not practical.**
- $F_{\text{baud}} / (2 * \text{PatternLength}) = 53.125 \text{ GBd} / (2 * 511) = 52 \text{ MHz} \gg 4 \text{ MHz CR loop BW}$

# EOJ Experiment: Evaluate Impact of CR Loop BW

**3 DUTs characterized. Tx Source configured for 53.125 GBd, PAM4, PRBS13Q:**

1. M8040A JBERT Pattern Generator
2. DUT#2 (53.125 GBd PAM4)
3. 106G PHY (53.125 GBd PAM4)

**Measure EOJ with two CR loop BW settings (100 measurements each) on the same oscilloscope setup (N1000A DCA-X +N1060A):**

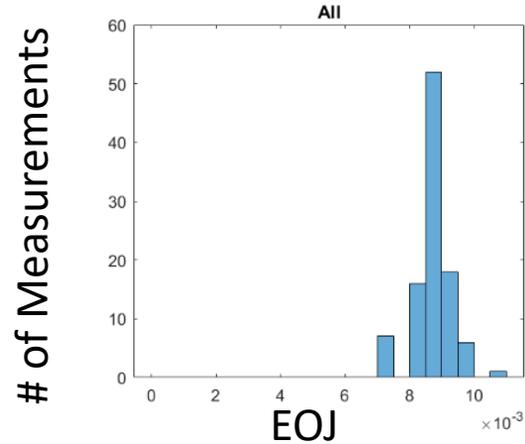
1. 4 MHz (currently specified by IEEE 802.3ck)
2. 106 kHz or 1 MHz

**Evaluate impact of CR Loop BW on EOJ results:**

1. EOJ Result
2. EOJ Distribution
3. EOJ Repeatability

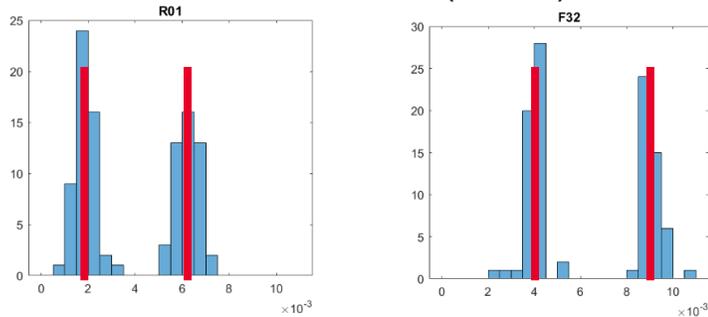
# DUT 1: M8040A JBERT Pattern Generator

CR Loop BW: 4 MHz (current spec)

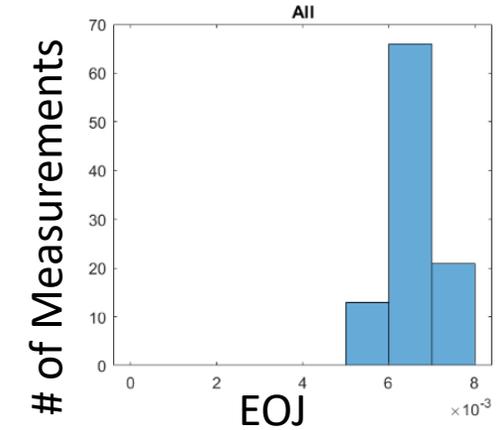


- EOJ Mean: 8.75mUI
- EOJ Min-Max: 7.5mUI - 10.5mUI (3 mUI)

“ALL” result looks “Normal” (above), but individual edges are bi-modal (below).

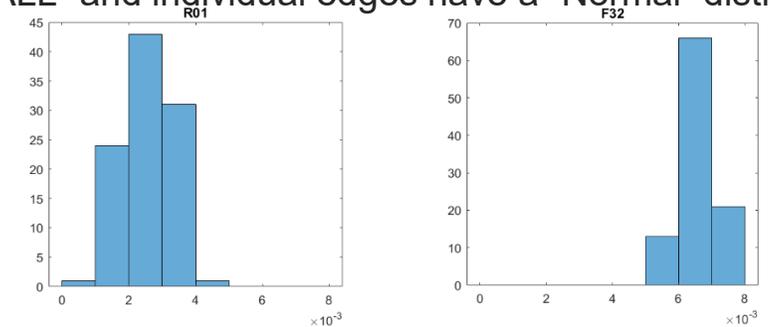


CR Loop BW: 106 kHz



- EOJ Mean: 6.3mUI
- EOJ Min – Max: 5.0mUI - 7.5mUI (2.5 mUI)

“ALL” and individual edges have a “Normal” distribution.

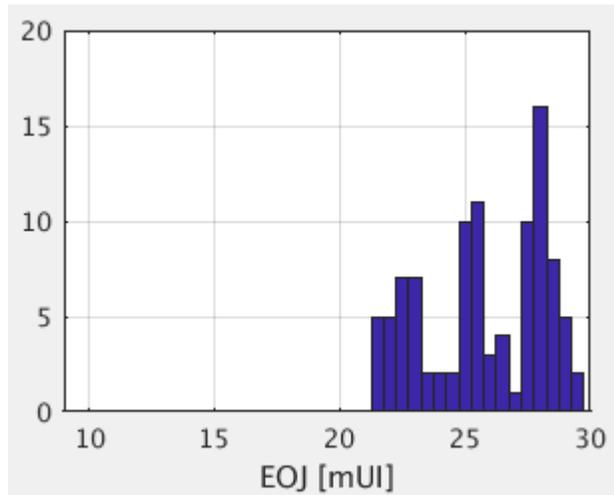


**Effect of lowering loop BW used to measure EOJ:**

- Mean is reduced (as expected per item#1 on slide 6)
- Bi-modal distribution is mitigated (as expected per item#2 on slide 6)
- Lower CR loop BW can improve EOJ measurement accuracy.

# DUT 2: 53.125 GBd PAM4 TX

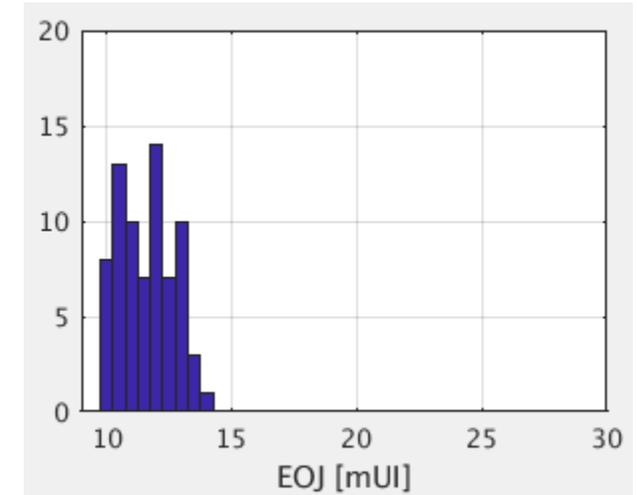
CR Loop BW: 4 MHz (current spec)



- EOJ Mean: 25.8 mUI
- EOJ Min-Max: 21.5mUI - 29.5mUI (8 mUI)



CR Loop BW: 1.06 MHz



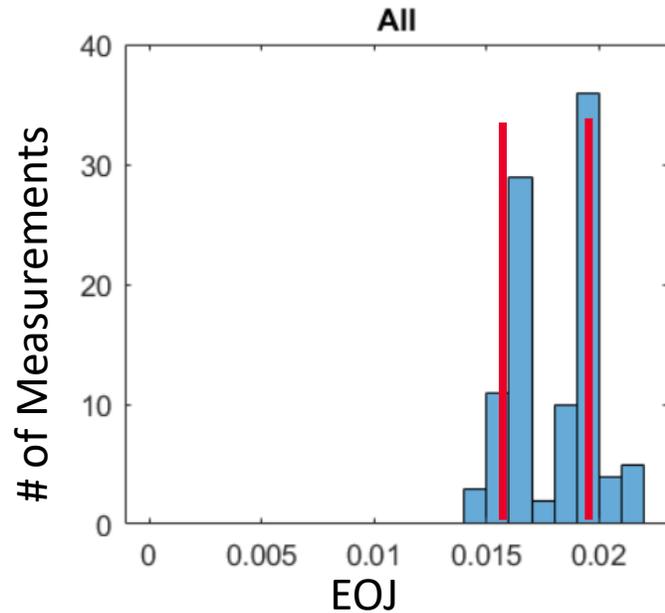
- EOJ Mean: 11.6 mUI
- EOJ Min-Max: 10 mUI – 14 mUI (4 mUI)

**Effect of lowering loop BW used to measure EOJ:**

- Mean is reduced (as expected per item#1 on slide 6)
- Lower CR loop BW can improve EOJ measurement accuracy.

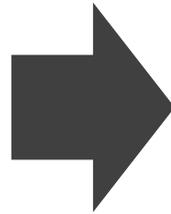
# DUT 3: 106 Gb/s PHY

CR Loop BW: 4 MHz (current spec)

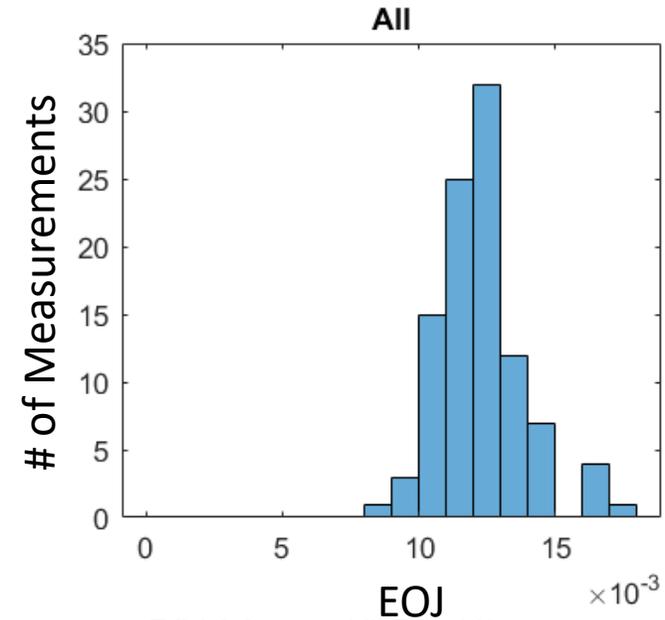


- EOJ Mean: 18.1 mUI
- EOJ Min-Max: 15.0 mUI - 21.0 mUI (6 mUI)

Bi-modal distribution in the “ALL” result  
(max of the 12 transitions).



CR Loop BW: 106 kHz



- EOJ Mean: 12.7 mUI
- EOJ Min-Max: 9.0 mUI - 17.0 mUI (8 mUI)

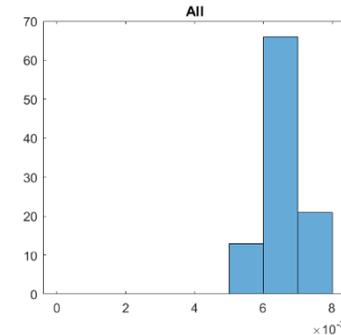
Normal distribution in “ALL” results and  
individual 12 transitions.

## Effect of lowering loop BW used to measure EOJ:

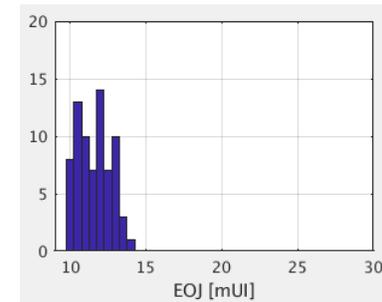
- Mean is reduced (as expected per item#1 on slide 6)
- Bi-modal distribution is mitigated (as expected per item#2 on slide 6)
- Lower CR loop BW can improve EOJ measurement accuracy.

# EOJ Measurement Repeatability

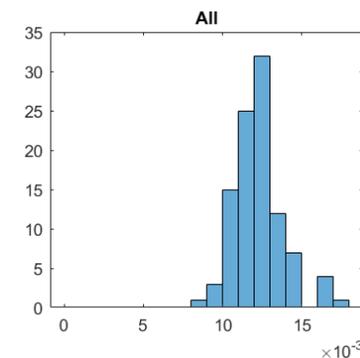
- Degraded signals (closed eyes, slower dV/dt, jitter, skew) generated by a “real” DUT will impact EOJ repeatability.
- @ 53.125 GBd:
  - EOJ max: 19 mUI = 358 fs
  - 1 mUI < 19 fs
- **Consider an increase EOJ max spec** to account for measurement repeatability of T&M equipment on “real” PAM4 signals.



- EOJ Mean: 6.3mUI
- **EOJ Min – Max: 5.0mUI - 7.5mUI (2.5 mUI)**



- EOJ Mean: 11.6 mUI
- **EOJ Min-Max: 10 mUI – 14 mUI (4 mUI)**



- EOJ Mean: 12.7 mUI
- **EOJ Min-Max: 9.0 mUI - 17.0 mUI (8 mUI)**

# Recommendations to support anticipated comments against Draft 1.3

## 1. Change CR Loop BW for EOJ measurements from “4 MHz” to “ $\leq 4$ MHz”. Add text to IEEE 802.3ck Draft 1.3:

### a. Section 162.9.3.3

- “Even-odd jitter is calculated using the measurement method specified in 120D.3.2.8.2 with the exception that EOJ may be measured with a clock recovery unit (CRU) with a corner frequency of  $\leq 4$  MHz and a slope of 20 dB/decade.

### b. Annex 120F.3.1.3

- “Even-odd jitter is calculated using the measurement method specified in 120D.3.2.8.2 with the exception that EOJ may be measured with a clock recovery unit (CRU) with a corner frequency of  $\leq 4$  MHz and a slope of 20 dB/decade.

## 2. Increase EOJ max spec to account for measurement repeatability of T&M equipment on “real” PAM4 signals.

- Table 162-10
- Table 120F-1

### 162.9.3.3 Output jitter

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Even-odd jitter is calculated using the measurement method specified in 120D.3.1.8.2.

### 120F.3.1.3 Output jitter

Output jitter is characterized by three parameters:  $J_{4u}$ ,  $J_{RMS}$ , and even-odd jitter. These parameters are calculated from measurements with a single transmit equalizer setting to compensate for the loss of the transmitter package and test fixture. The equalizer setting is chosen to minimize any or all of the jitter parameters.

$J_{4u}$  and  $J_{RMS}$  are calculated using the jitter measurement method specified in 120D.3.1.8.1.

Even-odd jitter is calculated using the jitter measurement method specified in 120D.3.1.8.2.

Even-odd jitter, pk-pk <sup>d</sup>	162.9.3.3	0.019	UI
Even-odd jitter (max)	120F.3.1.3	0.019	UI

(at 53 GBd, 1 mUI < 19 fs)